

STW45N60DM2AG

Automotive-grade N-channel 600 V, 0.085 Ω typ., 34 A MDmeshTM DM2 Power MOSFET in a TO-247 package

Datasheet - production data

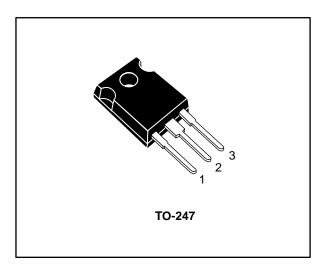
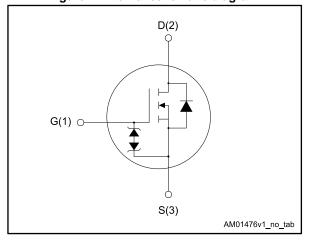


Figure 1: Internal schematic diagram



Features

Order code	V _{DS} @ T _{Jmax.}	R _{DS(on)} max.	I _D	Ртот
STW45N60DM2AG	650 V	0.093 Ω	34 A	250 W

- Designed for automotive applications and AEC-Q101 qualified
- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmeshTM DM2 fast recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{DS(on)}$, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STW45N60DM2AG	45N60DM2	TO-247	Tube

Contents STW45N60DM2AG

Contents

1	Electric	cal ratings	3
2	Electric	cal characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	rcuits	8
4	Packag	e information	9
	4.1	TO-247 package information	9
5	Revisio	on history	11

STW45N60DM2AG Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	±25	V
,	Drain current (continuous) at T _{case} = 25 °C	34	۸
I _D	Drain current (continuous) at T _{case} = 100 °C	21	A
I _{DM} ⁽¹⁾	Drain current (pulsed)	136	Α
P _{TOT}	Total dissipation at T _{case} = 25 °C	250	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	50	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/HS
T _{stg}	Storage temperature -55 to 150		°C
Tj	Operating junction temperature	-55 (0 150	

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.50	°C AA7
R _{thj-amb}	Thermal resistance junction-ambient	50	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive	6	Α
E _{AS} ⁽¹⁾	Single pulse avalanche energy	800	mJ

Notes:

 $^{^{\}left(1\right)}$ Pulse width is limited by safe operating area.

 $^{^{(2)}}$ $I_{SD} \leq 34$ A, di/dt=800 A/µs; V_{DS} peak < $V_{(BR)DSS},$ $V_{DD} =~80\%$ $V_{(BR)DSS}.$

 $^{^{(3)}}$ V_{DS} ≤ 480 V.

 $^{^{(1)}}$ starting $T_j = 25~^{\circ}C,~I_D = I_{AR},~V_{DD} = 50~V.$

Electrical characteristics STW45N60DM2AG

2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	600			>
	Zoro goto voltago	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$			1	
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V},$ $T_{case} = 125 \text{ °C}$			100	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±5	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	3	4	5	>
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 17 A		0.085	0.093	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		1	2500	-	
C _{oss}	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$	1	120	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	-	3	-	Pi
Coss eq. (1)	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$ V	-	200	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	1	4	-	Ω
Qg	Total gate charge	$V_{DD} = 480 \text{ V}, I_D = 34 \text{ A},$	1	56	-	
Q _{gs}	Gate-source charge	V _{GS} = 10 V (see <i>Figure 15</i> :	-	13	-	nC
Q_{gd}	Gate-drain charge	"Gate charge test circuit")	-	30	-	

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 25 \text{ A}$	1	29	-	
t _r	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see Figure 14: "Switching	1	27	-	
t _{d(off)}	Turn-off delay time	times test circuit for	-	85	-	ns
t _f	Fall time	resistive load" and Figure 19: "Switching time waveform")	-	6	-	

 $^{^{(1)}}$ $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Table 8: Source-drain diode

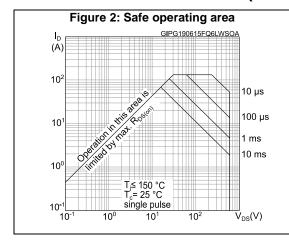
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		1		34	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		136	Α
V _{SD} ⁽²⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 34 A	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 34 A,	1	120		ns
Q _{rr}	Reverse recovery charge	di/dt = 100 A/µs, V _{DD} = 60 V (see Figure 16: "Test circuit for inductive	-	0.6		μC
I _{RRM}	Reverse recovery current	load switching and diode recovery times")	-	10.4		Α
t _{rr}	Reverse recovery time	I _{SD} = 34 A,	-	240		ns
Q _{rr}	Reverse recovery charge	di/dt = 100 A/µs, V _{DD} = 60 V, T _j = 150 °C (see <i>Figure 16: "Test</i>		2.4		μC
I _{RRM}	Reverse recovery current	circuit for inductive load switching and diode recovery times")	-	20.5		А

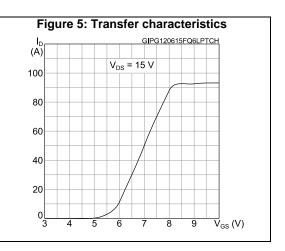
Notes:

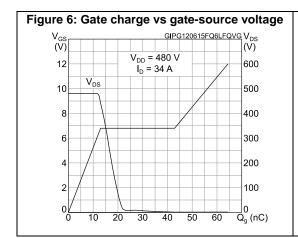
 $^{^{\}left(1\right) }$ Pulse width is limited by safe operating area.

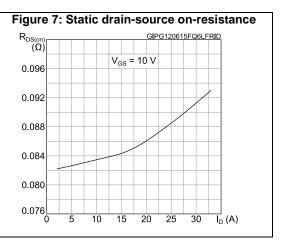
⁽²⁾ Pulse test: pulse duration = 300 μ s, duty cycle 1.5%.

2.1 Electrical characteristics (curves)









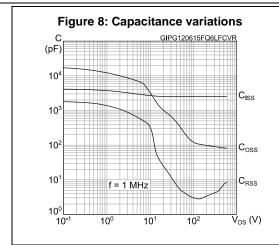


Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG120615F06LPRON

(norm.)

2.2

V_{GS} = 10 V

1.8

1.4

1.0

0.6

0.2

-75

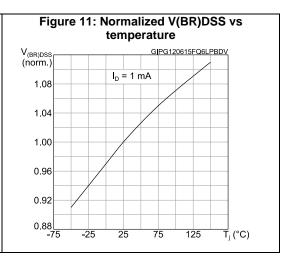
-25

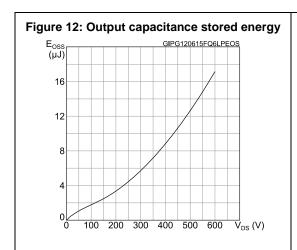
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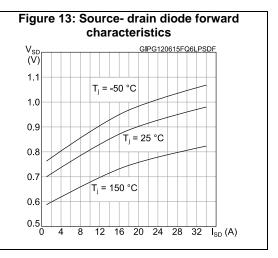
75

125

T_j (°C)

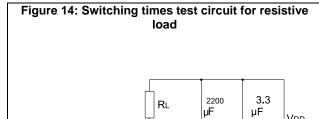






Test circuits STW45N60DM2AG

3 **Test circuits**



AM01468v1

Vdd

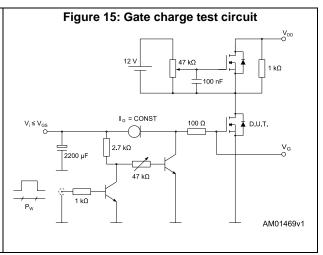


Figure 16: Test circuit for inductive load switching and diode recovery times

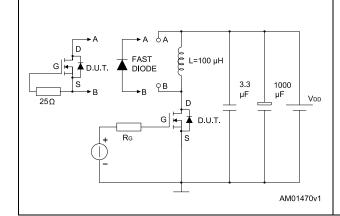
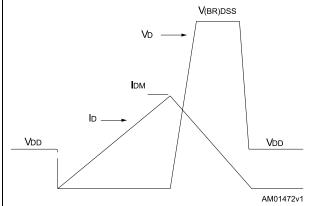
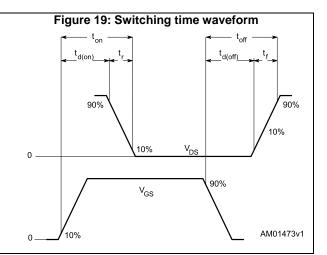


Figure 17: Unclamped inductive load test circuit 2200 VDD AM01471v1

Figure 18: Unclamped inductive waveform





4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-247 package information

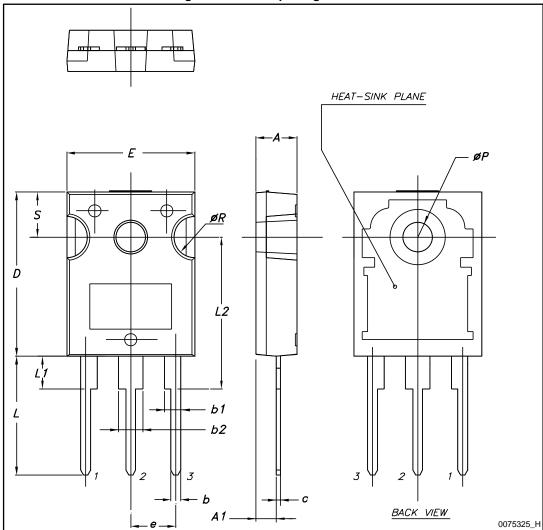


Figure 20: TO-247 package outline

Table 9: TO-247 package mechanical data

Dim		mm.	
Dim.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

STW45N60DM2AG Revision history

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
03-Jul-2015	1	Initial release.

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